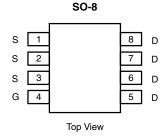


Vishay Siliconix

# P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$ Max.	I <sub>D</sub> <sup>a</sup>	Q <sub>g</sub> (Typ.)		
	0.0065 at V <sub>GS</sub> = - 10 V	- 29			
- 30	0.0082 at V <sub>GS</sub> = - 6 V	- 23	66 nC		
	0.0112 at V <sub>GS</sub> = - 4.5 V	- 20			



### Ordering Information:

Si4491EDY-T1-GE3 (Lead (Pb)-free and Halogen-free)

### **FEATURES**

Extended  $V_{GS}$  range (± 25 V) for adaptor switch applications



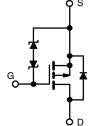
COMPLIANT **HALOGEN** 

FREE

- Extremely low R<sub>DS(on)</sub>
- TrenchFET® Power MOSFET
- 100 %  $R_q$  and UIS Tested
- Typical ESD Performance: 4000 V (HBM)
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912

### **APPLICATIONS**

- · Adaptor Switch, Load Switch
- **Power Management**
- Notebook Computers and Portable **Battery Packs**



P-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	- 30	V
Gate-Source Voltage		V <sub>GS</sub>	± 25	v
	T <sub>C</sub> = 25 °C		- 25.8	
Continuous Drain Current (T <sub>,J</sub> = 150 °C)	T <sub>C</sub> = 70 °C		- 20.7	
Continuous Diam Curient (1) = 130 C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 17.3	
	T <sub>A</sub> = 70 °C		- 13.9 <sup>b, c</sup>	Α
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	- 60	^
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I.	- 5.8 <sup>b, c</sup>	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	- I <sub>S</sub>	- 2.6 <sup>b, c</sup>	
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	- 40	
Single Pulse Avalanche Energy	L = 0.1 mm	E <sub>AS</sub>	80	mJ
	T <sub>C</sub> = 25 °C		6.9	
Mayimum Dawar Dissination	T <sub>C</sub> = 70 °C	P <sub>D</sub>	4.4	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		3.1 <sup>b, c</sup>	VV
	T <sub>A</sub> = 70 °C		2 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C

THERMAL RESISTANCE RATINGS								
Parameter	Symbol	Typical	Maximum	Unit				
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	33	40	°C/W			
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	15	17	J 0, W			

### Notes:

- a. Based on  $T_C = 25$  °C.
- b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 90 °C/W.

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<b>SPECIFICATIONS</b> ( $T_J = 25$ °C,	unless oth	erwise noted)					
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 uA		- 24		m\//°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	- I <sub>D</sub> = - 250 μA		6		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	- 1.2		- 2.8	V	
	ı	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			± 150		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 15		
Zone Ooto Walkens Busin Oursell		V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V			- 1	μΑ	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 20			Α	
		V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 13 A		0.0054	0.0065		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 6 V, I <sub>D</sub> = - 10 A		0.0068	0.0082	Ω	
		V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 8 A		0.0093	0.0112		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 13 A		44		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			4620			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		880		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			820			
Total Cata Chausa		V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 17.3 A		102	153		
Total Gate Charge	$Q_g$			66	80		
Gate-Source Charge	$Q_{gs}$	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 5 V, I <sub>D</sub> = - 17.3 A		16		nC	
Gate-Drain Charge	$Q_{gd}$			28			
Gate Resistance	$R_{g}$	f = 1 MHz	0.3	1.3	2.6	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			70	105		
Rise Time	t <sub>r</sub>	$V_{DD} = 0 \text{ V, R}_{L} = 1.5 \Omega$		70	105		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		45	68		
Fall Time	t <sub>f</sub>			27	41		
Turn-On Delay Time	t <sub>d(on)</sub>			18	30	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, R_L = 1.5 \Omega$		15	25	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -10 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		52	80		
Fall Time	t <sub>f</sub>			14	25		
Drain-Source Body Diode Characteristic							
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 5.8	۸	
Pulse Diode Forward Current	I <sub>SM</sub>				- 60	Α	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 10 A, V <sub>GS</sub> = 0 V		- 0.78	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			35	53	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 10 A dl/dt = 100 A/v = T = 05 °C		25	38	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		19			
Reverse Recovery Rise Time	t <sub>b</sub>			16		ns	

### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

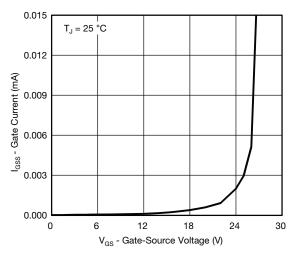
a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %

b. Guaranteed by design, not subject to production testing.

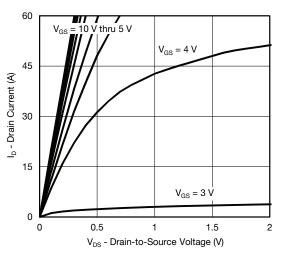


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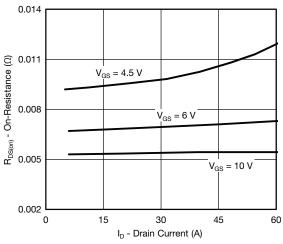
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



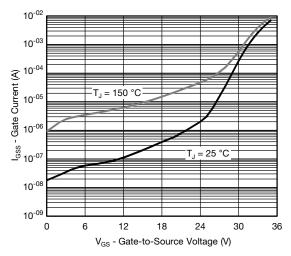
Gate Current vs. Gate-Source Voltage



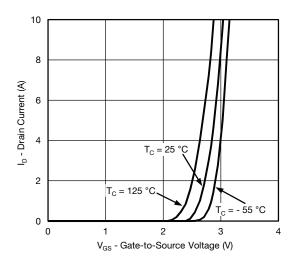
**Output Characteristics** 



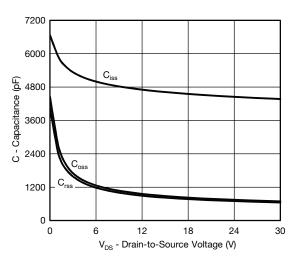
On-Resistance vs. Drain Current



Gate Current vs. Gate-Source Voltage



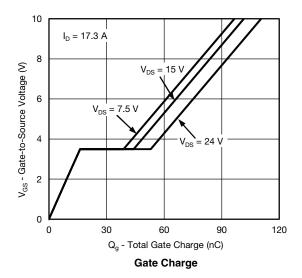
Transfer Characteristics

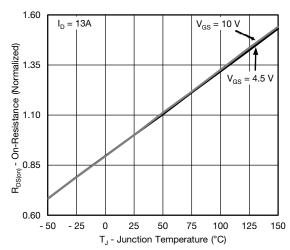


Capacitance

## Vishay Siliconix

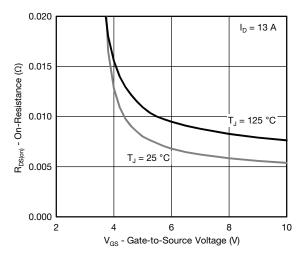
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



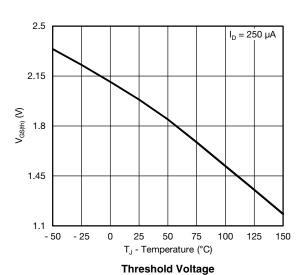


## 100 I<sub>S</sub> - Source Current (A) T<sub>J</sub> = 150 °C 25 °C 0.1 0.0 0.2 0.4 0.6 8.0 1.0 V<sub>SD</sub> - Source-to-Drain Voltage (V)

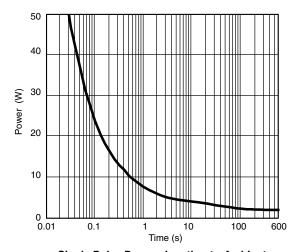
On-Resistance vs. Junction Temperature



Source-Drain Diode Forward Voltage



On-Resistance vs. Gate-to-Source Voltage

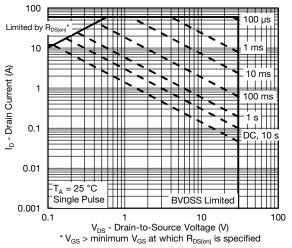


Single Pulse Power, Junction-to-Ambient

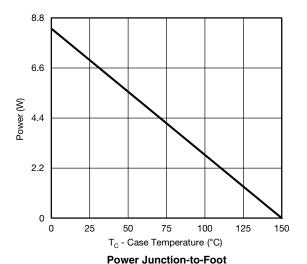


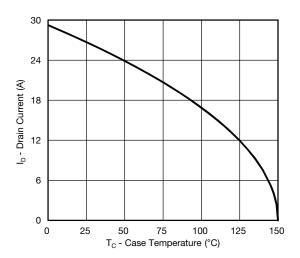
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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

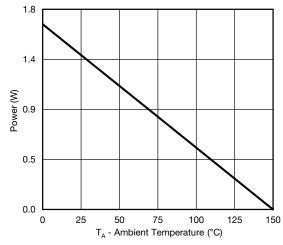


Safe Operating Area, Junction-to-Ambient





**Current Derating\*** 



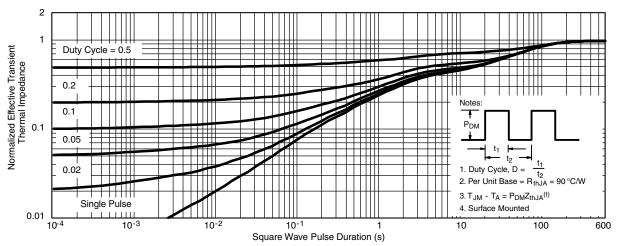
**Power Junction-to-Ambient** 

 $<sup>^*</sup>$  The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150  $^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

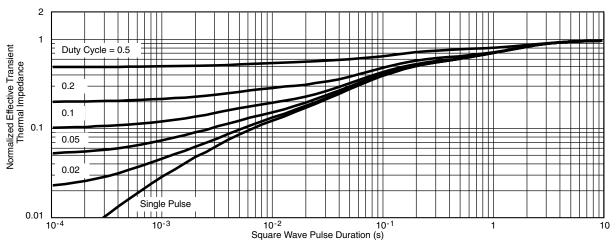
## Vishay Siliconix



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?63866.



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIMETERS			HES	
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A <sub>1</sub>	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
Е	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I. 11-Sep-06					

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06



### **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)

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